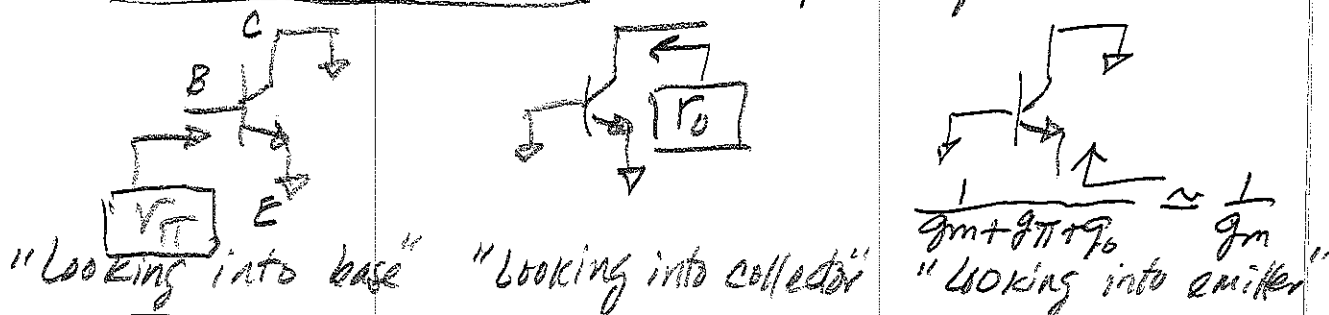


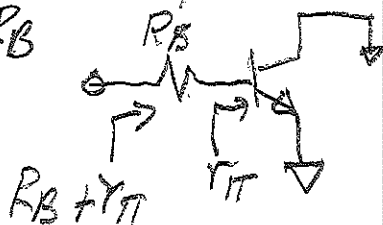
Today: • Inspection analysis of basic stages
 • CMOS gain stage analysis

Terminal resistances: (simple single transistor)



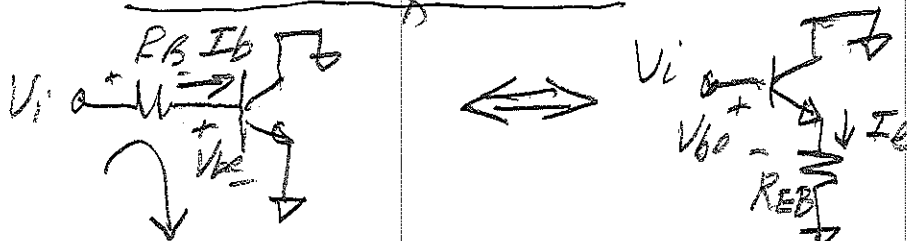
Now, let's extend by adding series resistances

→ (A) R_B



• Looking into emitter is slightly more complicated.

Form an equivalence:

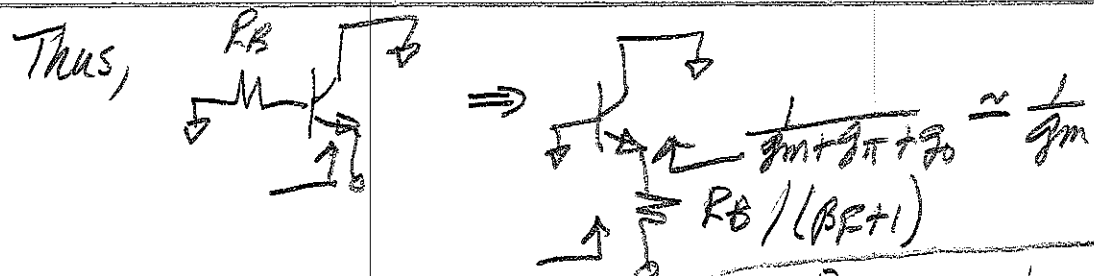


KCL: $V_i = V_{be} + I_b R_B$ KCL: $V_i = V_{be} + I_e R_{EB}$

$= V_{be} + (\beta_F + 1) I_b R_{EB}$

Equating \Rightarrow $R_{EB} = \frac{R_B}{\beta_F + 1}$

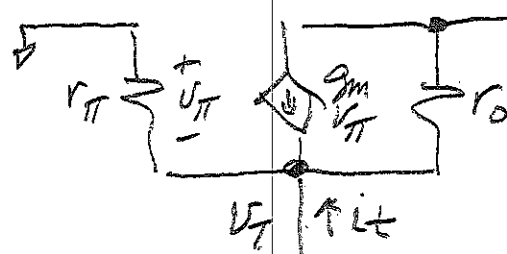
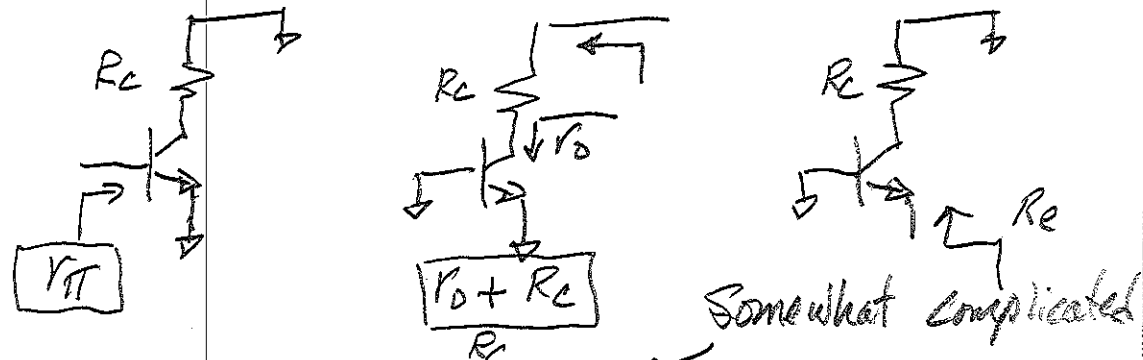
∴ To move a resistance from in series with base to in series with emitter, divide its value by $(\beta_F + 1)$
 Likewise, from emitter to base, multiply by $(\beta_F + 1)$.



$$\frac{1}{g_m + g_\pi + g_o} + \frac{R_B}{\beta + 1} \approx \frac{1}{g_m} + \frac{R_B}{\beta + 1}$$

AMERAD

(B) R_e



Write two KCL equations and solve:

$$R_e = \frac{g_o + g_c}{g_c (g_m + g_\pi + g_o) + g_o g_\pi} \approx \frac{1 + g_o / g_c}{g_m + \frac{g_o g_\pi}{R_e}}$$

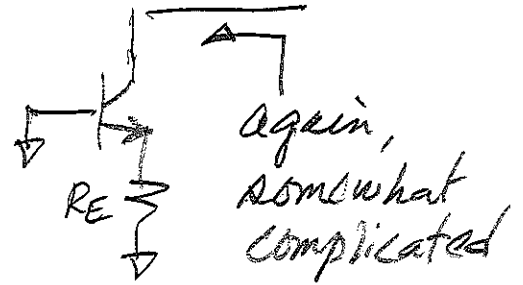
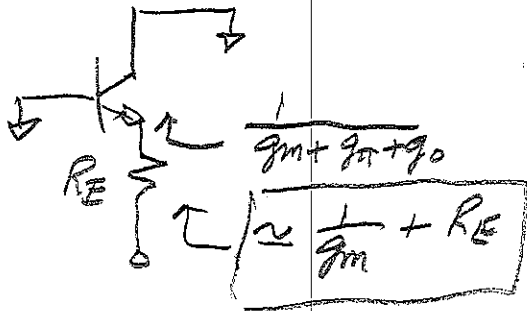
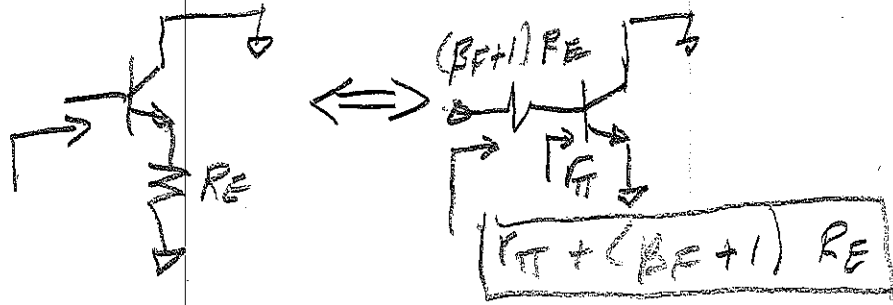
two cases: (i) R_e large $\approx r_o$ (i.e., $g_o \approx g_c$)

$$\therefore R_e \approx \frac{2}{g_m}$$

or (ii) R_e small $\ll r_o$ (discrete implementation)
($g_c \gg g_o$)

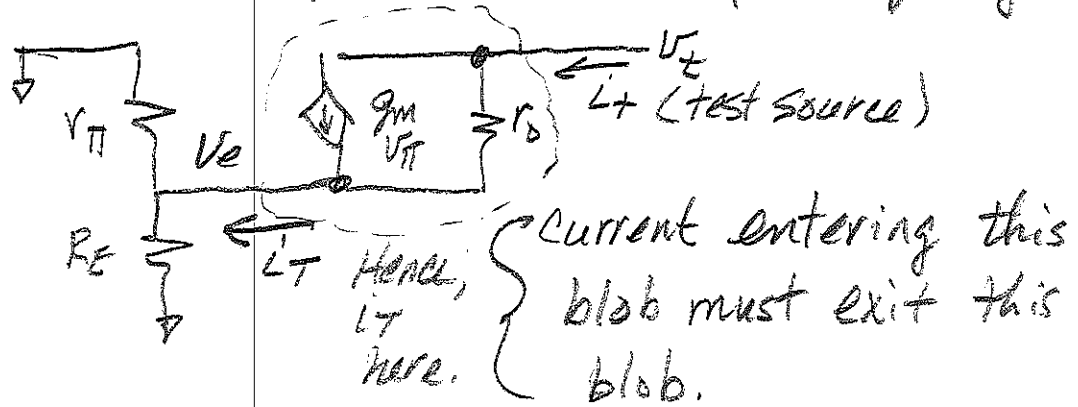
$$\therefore R_e \approx \frac{1}{g_m}$$

(C) R_E :



AHEAD

Draw small-signal model (funny looking way):



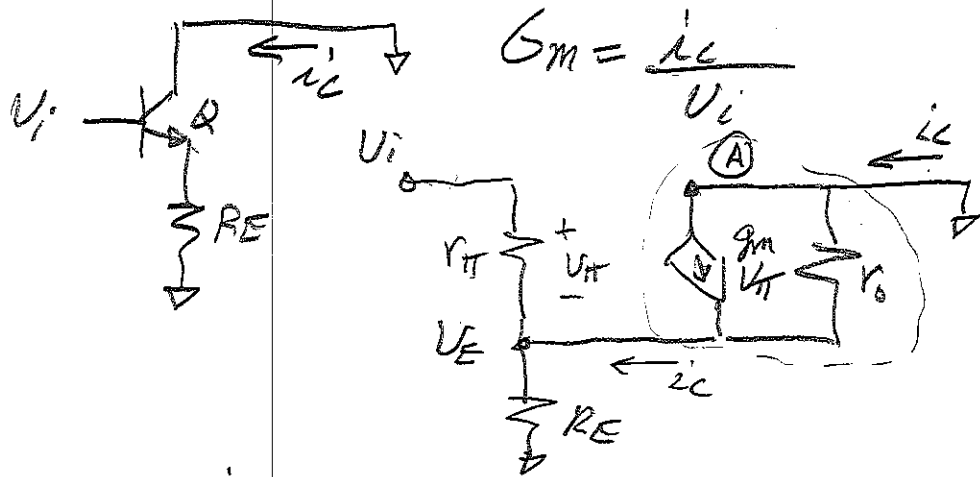
\therefore by inspection, $V_E = \frac{i_T}{(g_\pi + g_E)}$

Now, KCL at collector:

$$\begin{aligned} i_T &= g_m v_\pi + g_o (V_E - V_E) \\ &= g_m (V_E - V_E) + g_o (V_E - V_E) \\ &= -(g_m + g_o) V_E + g_o V_E \\ &= -(g_m + g_o) \frac{i_T}{g_\pi + g_E} + g_o V_E \end{aligned}$$

$$\begin{aligned} \therefore R_c = \frac{V_E}{i_T} &= \left(\frac{g_m + g_\pi + g_o + g_E}{g_\pi + g_E} \right) r_o \approx \left(\frac{g_m + g_E}{g_\pi + g_E} \right) r_o \\ &= \frac{(1 + g_m / g_E) r_o}{(1 + g_\pi / g_E)} = \frac{(1 + g_m R_E) r_o}{1 + g_m R_E / \beta} \approx \boxed{g_m R_E r_o} \end{aligned}$$

- Small-signal transconductance with emitter degeneration, $G_m \neq g_m$:



$$V_e = \frac{i_c}{g_\pi + g_E} \quad (\text{By inspection})$$

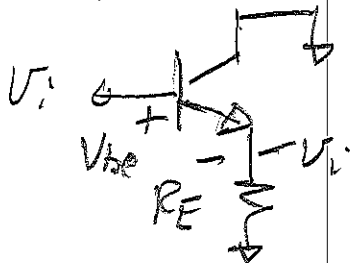
Now, KCL at (A):

$$\begin{aligned} i_c &= g_m V_\pi + g_o (0 - V_e) \\ &= g_m (V_i - V_e) + g_o (0 - V_e) \\ &= g_m V_i - V_e (g_m + g_o) \\ &= g_m V_i - \frac{(g_m + g_o)}{(g_\pi + g_E)} i_c \end{aligned}$$

$$\therefore G_m = \frac{g_m}{1 + g_m R_E}$$

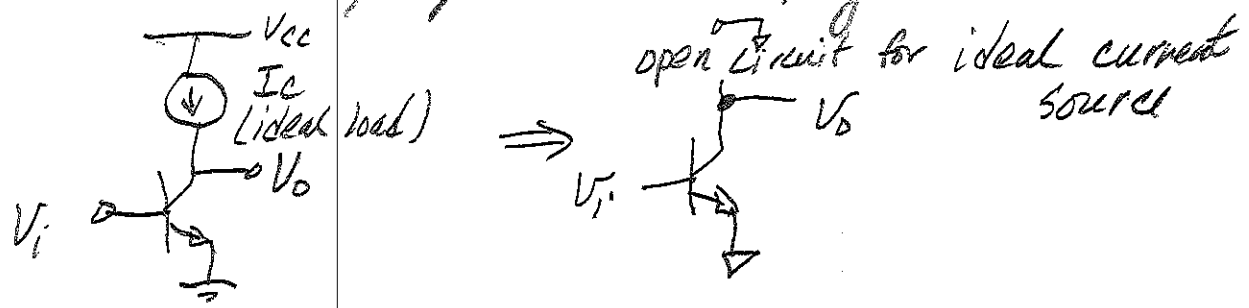
Usually, $g_m R_E \gg 1 \Rightarrow G_m \approx \frac{1}{R_E}$

How do we see this by inspection.



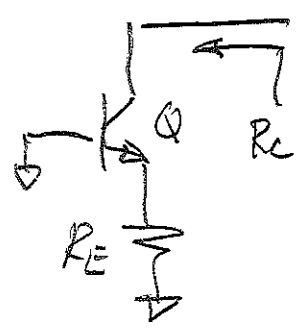
If we assume V_{be} is constant at $V_{be} = V_{BE} = 0.7V$, then signal V_i appears across R_E
 $\therefore I_E = \frac{V_i}{R_E} \approx I_C \therefore G_m = \frac{1}{R_E}$

- An important voltage gain limitation = "open-circuit voltage gain" or "self gain"



Quick s.s. analysis: $A_V = \frac{V_o}{V_i} = -g_m r_o$

- This is extraordinarily useful in inspection analysis: $= -\frac{I_C}{V_T} \cdot \frac{V_A}{I_C} = \boxed{-\frac{V_A}{V_T}}$



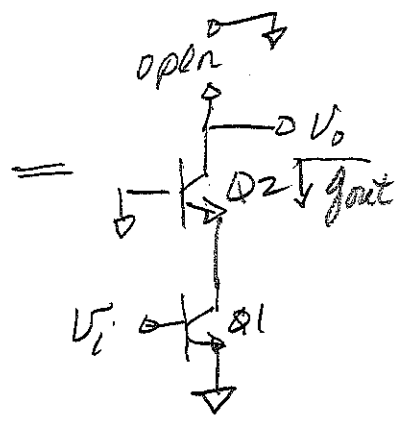
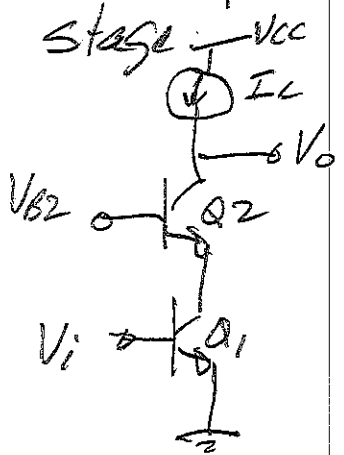
Recall from previous analysis:

$R_c \approx g_m R_E r_o$ (Bottom page 28)

Rearrange: $R_c = (g_m r_o) R_E$ ***

Series resistance is multiplied by self-gain of Q

This is powerful. Consider a cascode gain stage

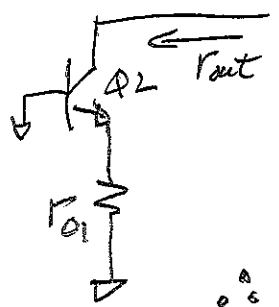
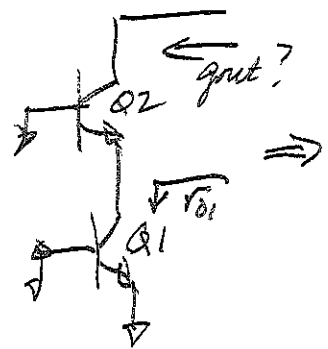


As we know,

$A_V = -g_m / g_{out}$

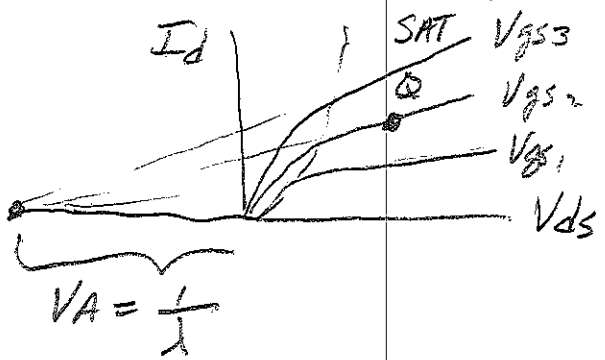
What is g_{out} ?

ARTAD



$r_{out} \approx (g_{m2} r_{o2}) r_{o1}$
 $\therefore A_v = -g_{m1} g_{m2} r_{o2} r_{o1}$
 $= -(g_{m1} r_{o1})(g_{m2} r_{o2})$
 \therefore Cascode gives gain of two simple stage but only uses one shared bias current

MOSFET Small-Signal models:



Saturation:
 $V_{gs} > V_T$ and $V_{ds} > (V_{gs} - V_T)$
 V_T threshold voltage not thermal voltage

$$I_D = \frac{k_n'}{2} \left(\frac{W}{L}\right) (V_{gs} - V_T)^2 (1 + \lambda V_{ds})$$

$$g_{ds} = \left. \frac{\partial I_D}{\partial V_{ds}} \right|_Q = \frac{\lambda I_D}{1 + \lambda V_{ds}} \approx \boxed{\lambda I_D} \leftarrow$$

Otherwise, including for DC calculations, neglect channel-length modulation term:

$$I_D = \frac{k_n'}{2} \left(\frac{W}{L}\right) (V_{gs} - V_T)^2$$

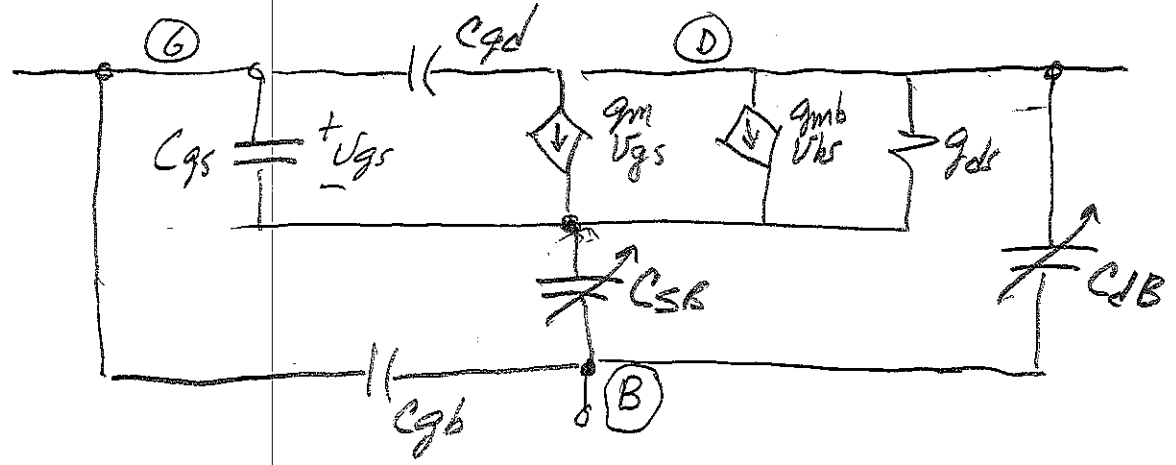
$$g_m = \left. \frac{\partial I_D}{\partial V_{gs}} \right|_Q = \boxed{k_n' \left(\frac{W}{L}\right) (V_{gs} - V_T)} \leftarrow \#1$$

$$= \boxed{\frac{2 I_D}{(V_{gs} - V_T)}} \leftarrow \#2 \text{ (most like BJT)}$$

$$= \sqrt{2 k_n' \left(\frac{W}{L}\right) I_D} \leftarrow \#3$$

$$g_{mb} = \left. \frac{\partial I_D}{\partial V_{bs}} \right|_Q = \text{Back-gate transconductance}$$

$$= \frac{\gamma}{2 + V_{SB} + 2\phi_f} \cdot g_m$$



Complete MOSFET small-signal model:

AMRANI